

July 2013

FDMS2506SDC

N-Channel Dual CoolTM PowerTrench[®] SyncFETTM 25 V, 49 A, 1.45 m Ω

Features

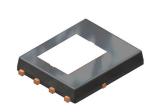
- Dual CoolTM Top Side Cooling PQFN package
- Max $r_{DS(on)}$ = 1.45 m Ω at V_{GS} = 10 V, I_D = 30 A
- Max $r_{DS(on)}$ = 2.1 m Ω at V_{GS} = 4.5 V, I_D = 26 A
- High performance technology for extremely low r_{DS(on)}
- SyncFET Schottky Body Diode
- RoHS Compliant

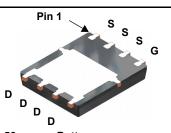
General Description

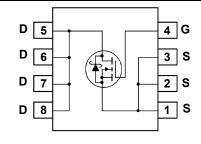
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process. Advancements in both silicon and Dual Cool package technologies have been combined to offer the lowest $r_{\text{DS(on)}}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance. This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side







Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			25	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		49	
I _D	-Continuous (Silicon limited)	T _C = 25 °C		202	A
	-Continuous	T _A = 25 °C	(Note 1a)	39	^
	-Pulsed			200	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	220	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 5)	1.6	V/ns
В	Power Dissipation	T _C = 25 °C		89	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	3.3	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.7	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.4	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
2506S	FDMS2506SDC	Dual Cool TM Power 56	13"	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_DSS	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		21		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20 V, V _{GS} = 0 V			500	μА
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$	1.2	1.7	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		-5		mV/°C
		V _{GS} = 10 V, I _D = 30 A		1.2	1.45	
r _{DS(on)}	r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 26 \text{ A}$		1.6	2.1	mΩ
, ,		$V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}, T_J = 125 \text{ °C}$		1.6	2.0	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 30 A		171		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 40 V V - 0 V	4470	5945	pF
Coss	Output Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	1200	1560	рF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	244	370	pF
R_g	Gate Resistance		8.0	1.8	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		16	29	ns
t _r	Rise Time	V _{DD} = 13 V, I _D = 30 A,	7.4	15	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	41	66	ns
t _f	Fall Time		4.8	10	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	66	93	nC
Q_{g}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 13 \text{ V},$	30	43	nC
Q _{gs}	Gate to Source Gate Charge	I _D = 30 A	13.4		nC
Q_{gd}	Gate to Drain "Miller" Charge		7.5		nC

Drain-Source Diode Characteristics

V Source to Drain Diade, Fenuer	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2 \text{ A}$ (Note 2)	0.40	0.7	W
V SD	Source to Drain Diode Forward voltage	$V_{GS} = 0 \text{ V}, I_S = 30 \text{ A}$ (Note 2)	0.76	1.2	, v
t _{rr}	Reverse Recovery Time	- I _E = 30 A, di/dt = 300 A/μs	35	56	ns
Q_{rr}	Reverse Recovery Charge	- 1 _F = 30 A, αι/αι = 300 A/μs	39	63	nC

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.7	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.4	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	C/VV
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

NOTES

1. R_{0,JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0,JC} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in 2 pad of 2 oz copper
- d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. E_{AS} of 220 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 21 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 32 A.
- 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.
- 5. $I_{SD} \le 30$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_J = 25 °C.

Typical Characteristics T_J = 25 °C unless otherwise noted

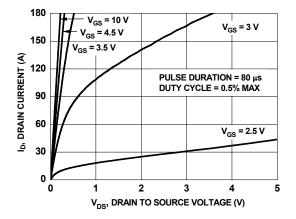


Figure 1. On-Region Characteristics

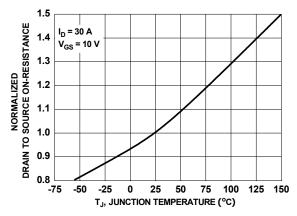


Figure 3. Normalized On-Resistance vs Junction Temperature

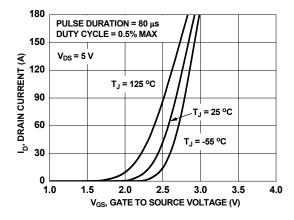


Figure 5. Transfer Characteristics

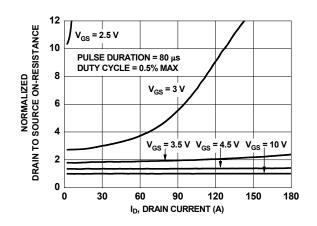


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

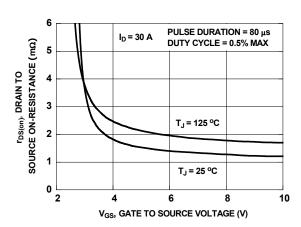


Figure 4. On-Resistance vs Gate to Source Voltage

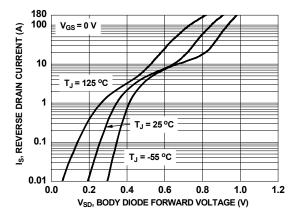


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 $^{\circ}$ C unless otherwise noted

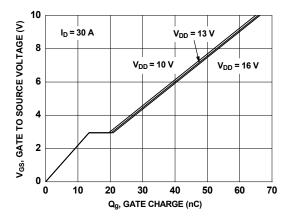


Figure 7. Gate Charge Characteristics

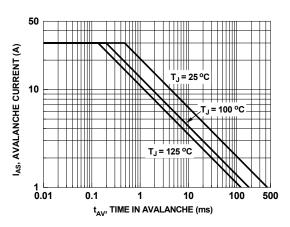


Figure 9. Unclamped Inductive Switching Capability

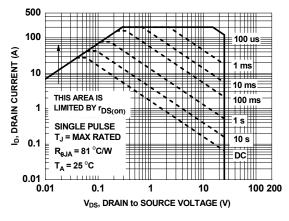


Figure 11. Forward Bias Safe Operating Area

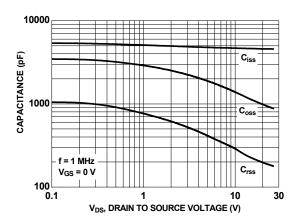


Figure 8. Capacitance vs Drain to Source Voltage

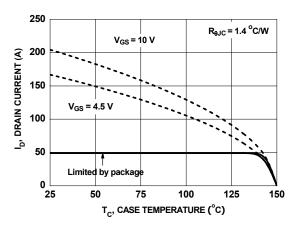


Figure 10. Maximum Continuous Drain Current vs Case Temperature

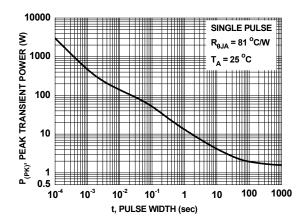


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

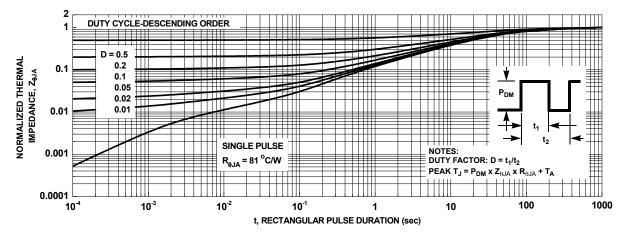


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS2506SDC.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

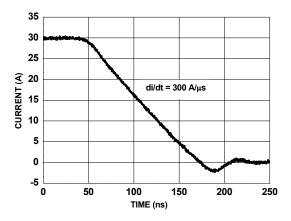


Figure 14. FDMS2506SDC SyncFET body diode reverse recovery characteristic

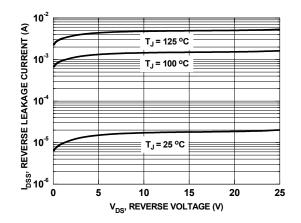
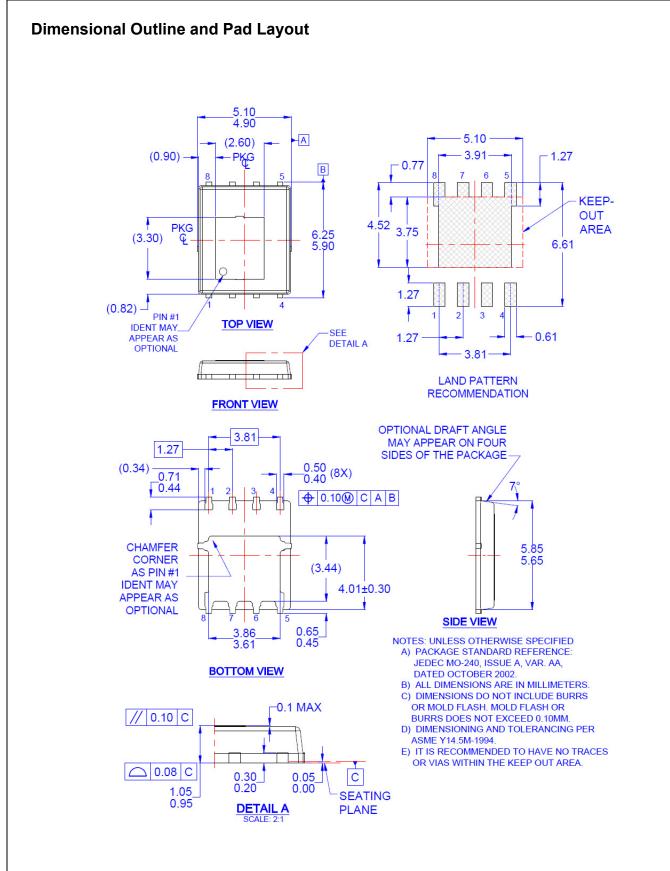


Figure 15. SyncFET body diode reverse leakage versus drain-source voltage







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